

Application/Control No.	Applicant(s)/Patent under Reexamination
10/660,388	CHU ET AL.
Examiner	Art Unit
Matthew J. Sked	2626

	SEARCHED			
Class	Subclass	Date	Examiner	
		-		

INTERFERENCE SEARCHED		
Subclass	Date	Examiner

SEARCH (INCLUDING SEAR	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR		
EAST Search Attached .	5/30/2007	9925		
INSPEC Search	5/31/2007	918		
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